

Notice of References Cited	Application/Control No. 09/780,673	Applicant(s)/Patent Under Reexamination HAN, JONG-HEE	
	Examiner Vivek Srivastava	Art Unit 2617	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	B	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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